

# PMZ390UN

# N-channel TrenchMOS standard level FET

Rev. 01 — 12 July 2007

**Product data sheet** 

## **Product profile**

### 1.1 General description

N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology.

#### 1.2 Features

- Profile 55 % lower than SOT23
- Low on-state resistance
- Leadless package

- Footprint 90 % smaller than SOT23
- Fast switching
- Standard level compatible threshold

### 1.3 Applications

Driver circuits

Load switching in portable appliances

#### 1.4 Quick reference data

- $V_{DS} \le 30 \text{ V}$
- $R_{DSon} \le 460 \text{ m}\Omega$

- $I_D \le 1.78 \text{ A}$
- $P_{tot} \le 2.50 \text{ W}$

#### **Pinning information** 2.

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		_		

10010 11	9		
Pin	Description	Simplified outline	Symbol
1	gate (G)		_
2	source (S)	1 3	D
3	drain (D)	2	$G \longrightarrow \overline{A}$
		Transparent top view	
		SOT883 (SC-101)	mbb076 S



### N-channel TrenchMOS standard level FET

# 3. Ordering information

Table 2. Ordering information

Type number	Package				
	Name	Description	Version		
PMZ390UN	SC-101	leadless ultra small plastic package; 3 solder lands; body 1.0 $\times$ 0.6 $\times$ 0.5 mm	SOT883		

## 4. Limiting values

#### CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

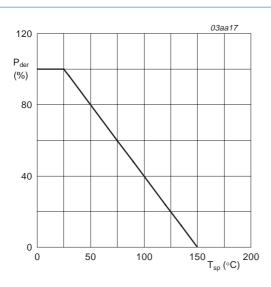
Such precautions are described in the *ANSI/ESD S20.20*, *IEC/ST 61340-5*, *JESD625-A* or equivalent standards.

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

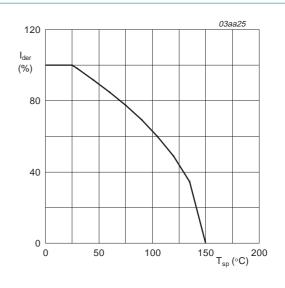
Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>DS</sub>	drain-source voltage	25 °C ≤ T <sub>i</sub> ≤ 150 °C	-	30	V
$V_{DGR}$	drain-gate voltage (DC)	$25  ^{\circ}\text{C} \le \text{T}_{\text{j}} \le 150  ^{\circ}\text{C};  \text{R}_{\text{GS}} = 20  \text{k}\Omega$	-	30	V
$V_{GS}$	gate-source voltage		-	±8	V
I <sub>D</sub>	drain current	$T_{mb}$ = 25 °C; $V_{GS}$ = 10 V; see <u>Figure 2</u> and <u>3</u>	-	1.78	Α
		$T_{mb} = 100  ^{\circ}\text{C};  V_{GS} = 10  \text{V};  \text{see}  \frac{\text{Figure 2}}{}$	-	1.13	Α
I <sub>DM</sub>	peak drain current	$T_{mb}$ = 25 °C; pulsed; $t_p \le 10 \mu s$ ; see Figure 3	-	3.56	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 1</u>	-	2.50	W
T <sub>stg</sub>	storage temperature		-55	+150	°C
Tj	junction temperature		-55	+150	°C
Source-	drain diode				
Is	source current	T <sub>mb</sub> = 25 °C	-	1.78	Α
I <sub>SM</sub>	peak source current	$T_{mb}$ = 25 °C; pulsed; $t_p \le 10 \mu s$	-	3.56	Α
Electros	tatic discharge				
V <sub>esd</sub>	electrostatic discharge voltage	all pins			
		human body model; C = 100 pF; R = 1.5 k $\Omega$	-	60	V
		machine model; C = 200 pF	-	30	V

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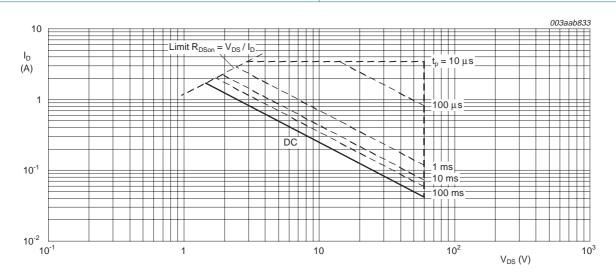
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100 \%$$

Fig 1. Normalized total power dissipation as a function of solder point temperature



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100 \%$$

Fig 2. Normalized continuous drain current as a function of solder point temperature



 $T_{mb}$  = 25 °C;  $I_{DM}$  is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

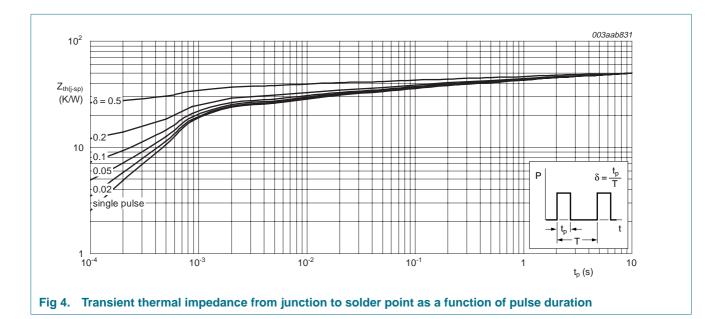
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## 5. Thermal characteristics

Table 4. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{\text{th(j-sp)}}$	thermal resistance from junction to solder point	see Figure 4	-	-	50	K/W
$R_{\text{th(j-a)}}$	thermal resistance from junction to ambient		<u>[1]</u> _	670	-	K/W

[1] Mounted on a printed-circuit board; vertical in still air.



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## 6. Characteristics

Table 5. Characteristics

 $T_j = 25 \,^{\circ}C$  unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static ch	aracteristics					
V <sub>(BR)DSS</sub> drain-source breakdown	$I_D = 10 \mu A; V_{GS} = 0 V$					
	voltage	T <sub>j</sub> = 25 °C	30	-	-	V
		T <sub>j</sub> = −55 °C	27	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 0.25 \text{ mA}$ ; $V_{DS} = V_{GS}$ ; see Figure 9 and 10				
		T <sub>j</sub> = 25 °C	0.45	0.7	0.95	V
		T <sub>j</sub> = 150 °C	0.25	-	-	V
		T <sub>j</sub> = −55 °C	-	-	1.15	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}$				
		T <sub>j</sub> = 25 °C	-	-	1	μΑ
		T <sub>j</sub> = 150 °C	-	-	100	μΑ
$I_{GSS}$	gate leakage current	$V_{GS} = \pm 8 \text{ V}; V_{DS} = 0 \text{ V}$	-	10	100	nΑ
R <sub>DSon</sub>	drain-source on-state	$V_{GS} = 4.5 \text{ V}$ ; $I_D = 0.2 \text{ A}$ ; see Figure 6 and 8				
	resistance	T <sub>j</sub> = 25 °C	-	390	460	$m\Omega$
		T <sub>j</sub> = 150 °C	-	663	782	$m\Omega$
		$V_{GS} = 2.5 \text{ V}$ ; $I_D = 0.1 \text{ A}$ ; see Figure 6 and 8	-	460	560	$m\Omega$
		$V_{GS}$ = 1.8 V; $I_D$ = 0.075 A; see <u>Figure 6</u> and <u>8</u>	-	550	730	$m\Omega$
Dynamic	characteristics					
Q <sub>G(tot)</sub>	total gate charge	$I_D = 1 \text{ A}; V_{DS} = 15 \text{ V}; V_{GS} = 4.5 \text{ V};$	-	0.89	-	nC
$Q_{GS}$	gate-source charge	see Figure 11 and 12	-	0.1	-	nC
$Q_{GD}$	gate-drain charge		-	0.2	-	nC
C <sub>iss</sub>	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$	-	43	-	pF
C <sub>oss</sub>	output capacitance	see Figure 14	-	7.7	-	pF
C <sub>rss</sub>	reverse transfer capacitance		-	4.8	-	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS}$ = 15 V; $R_L$ = 15 $\Omega$ ; $V_{GS}$ = 10 V; $R_G$ = 6 $\Omega$	-	4	-	ns
t <sub>r</sub>	rise time		-	7.5	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	18	-	ns
t <sub>f</sub>	fall time		-	4.5	-	ns
Source-	drain diode					
$V_{SD}$	source-drain voltage	$I_S = 0.3 \text{ A}$ ; $V_{GS} = 0 \text{ V}$ ; see <u>Figure 13</u>	-	0.76	1.2	V

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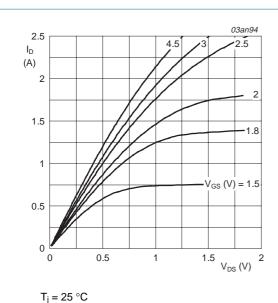


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

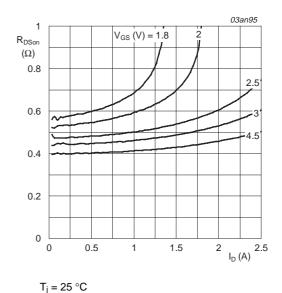
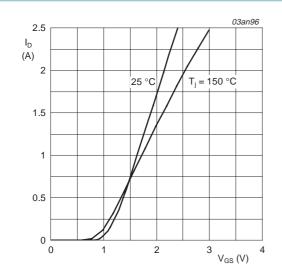
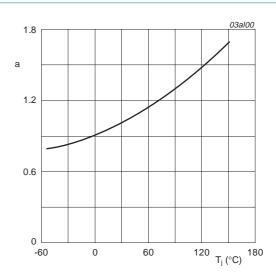


Fig 6. Drain-source on-state resistance as a function of drain current; typical values



 $T_j$  = 25 °C and 150 °C;  $V_{DS} > I_D \times R_{DSon}$ 

Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values

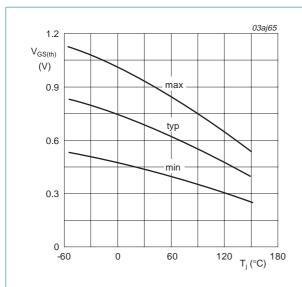


$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature

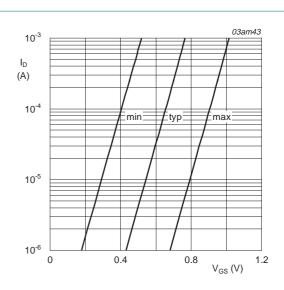
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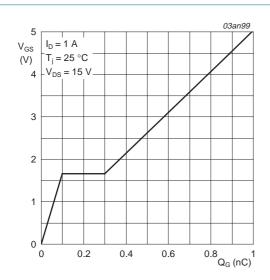
 $I_D = 1 \text{ mA}; V_{DS} = V_{GS}$ 

Fig 9. Gate-source threshold voltage as a function of junction temperature



 $T_j$  = 25 °C;  $V_{DS}$  = 5 V

Fig 10. Sub-threshold drain current as a function of gate-source voltage



I<sub>D</sub> = 1 A; V<sub>DS</sub> = 15 V

Fig 11. Gate-source voltage as a function of gate charge; typical values

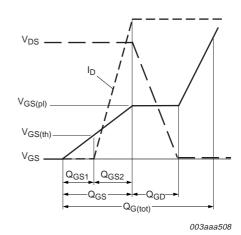
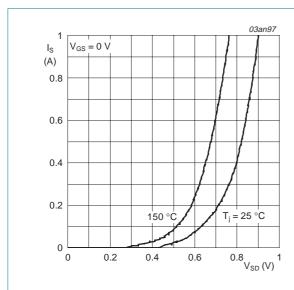


Fig 12. Gate charge waveform definitions

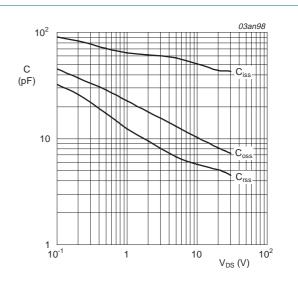
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 $T_j$  = 25 °C and 150 °C;  $V_{GS}$  = 0 V

Fig 13. Source current as a function of source-drain voltage; typical values



 $V_{GS} = 0 V$ ; f = 1 MHz

Fig 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

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03-04-03

## 7. Package outline

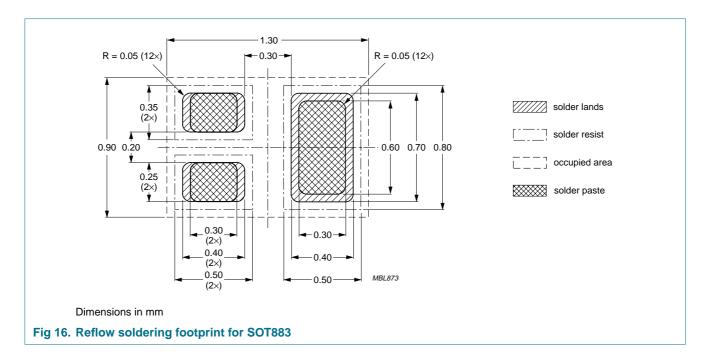
Leadless ultra small plastic package; 3 solder lands; body 1.0 x 0.6 x 0.5 mm **SOT883** e<sub>1</sub> 0.5 1 mm DIMENSIONS (mm are the original dimensions) UNIT  $b_1$ D Ε е  $\mathsf{L}_1$ e<sub>1</sub> 0.50 0.20 0.55 0.62 1.02 0.30 0.30 mm 0.03 0.35 0.65 0.46 0.95 0.22 0.22 1. Including plating thickness REFERENCES EUROPEAN OUTLINE ISSUE DATE VERSION **PROJECTION** IEC **JEDEC JEITA** 03-02-05 SOT883 SC-101

Fig 15. Package outline SO883 (SC-101)

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#### N-channel TrenchMOS standard level FET

# 8. Soldering



### N-channel TrenchMOS standard level FET

# 9. Revision history

### Table 6. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PMZ390UN _1	20070712	Product data sheet	-	-

#### N-channel TrenchMOS standard level FET

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#### 10.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions"
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